Wide-field Infrared Survey Explorer (WISE)

Subsystem Design Specification: WISE Photometry (WPHOT)

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1 INTRODUCTION

1.1 Document Scope

This Subsystem Design Specification (SDS) document describes the design of the WISE Photometry module (WPHOT) for the WISE Science Data System (WSDS). The purpose of WPHOT is to characterize the source candidates detected by the MDET module (described in Document WSDC D-004).

1.2 Applicable Documents

This plan conforms to the specifications in the following project documents:

- 1. WISE Science Data System (WSDS) Functional Requirements Document (WSDC D-R001).
- 2. WSDS Functional Design Document (WSDC D-D001).
- 3. MDET Subsystem Design Specification (WSDC D-004).
- 4. AWAIC Subsystem Design Specification (WSDC D-D005).
- 5. Software Interface Specification for call to WPHOT.
- 6. Software Interface Specification for output to source extraction database.

1.3 Requirements

The following requirements (from the WSDC Functional Requirements Document) are relevant related to the design of WPHOT:

- L4WSDC-002: The WSDC shall produce a Source Catalog derived from the images used to generate the WISE digital Image Atlas.
- L4WSDC-080: The final WISE Source Catalog shall have greater than 99.9% reliability for sources detected in at least one band with SNR>20, where the noise includes flux errors due to zodiacal foreground emission, instrumental effects, source photon statistics, and neighboring sources. This requirement shall not apply to sources that are superimposed on an identified artifact.
- L4WSDC-009: The final WISE Source Catalog shall be at least 95% complete for sources detected with SNR>20 in at least one band, where the noise includes flux errors due to zodiacal foreground emission, instrumental effects, source photon statistics, and neighboring sources. This requirement shall not apply to sources that are superimposed on an identified artifact.
- $L_4WSDC-010$: The final WISE Source Catalog shall include sources down to SNR=5 in any band, and the completeness and reliability of sources in the Catalog shall be characterized at all flux levels.
- LAWSDC-012: Flux measurements in the WISE Source Catalog shall have a SNR of five or more for point sources with fluxes of 0.12, 0.16, 0.65 and 2.6 mJy at 3.3, 4.7, 12 and 23 micrometers, respectively, assuming 8 independent exposures and where the noise flux errors due to zodiacal foreground emission, instrumental effects, source photon statistics, and neighboring sources.
- L4WSDC-013: The root mean square error in relative photometric accuracy in the WISE Source Catalog shall be better than 7% in each band for unsaturated point sources with $SNR>100$, where the noise flux errors due to zodiacal foreground emission, instrumental effects, source photon statistics, and neighboring sources. This requirement shall not apply to sources that superimposed on an identified artifact.
- $L4WSDC-015$: The WISE Source Catalog shall contain the measured in-band fluxes or flux upper-limits in the four WISE bands for objects detected in at least one band in the WISE Atlas Images.
- L4WSDC-016: The WISE Source Catalog shall contain uncertainties in the flux measurements (one sigma) in all bands for which a source is detected.
- L4WSDC-018: The WISE Source Catalog shall contain uncertainties in the coordinates measurements for each object.
- L4WSDC-043: The WSDS Pipeline processing shall detect sources down to a threshold of at least five times the image noise from the calibrated image frames, and the combined Atlas Images.
- $L_4WSDC-044$: The WSDS Pipeline processing shall merge source detections in the four WISE bands into a single source catalog entry.
- L_{4WSDC-049}: The WSDS Pipeline shall be robust to data missing from one or more bands.

1.4 Acronyms

- AWAIC A Wise Astronomical Image Coadder; the name of the module used to combine a set of focal-plane images to produce an estimate of the intensity distribution on the sky.
	- FITS Flexible Image Transport System.
- FWHM Full Width at Half Maximum.
- MDET Multiband DETector; the name of the module whose purpose is to produce a list of candidate source detections.
	- PSF Point Spread Function, defined here as the response of a focal plane pixel to a point source, as a function of position on the sky.
	- SNR Signal to noise ratio, defined here as the ratio of peak detection signal to the standard deviation of additive noise.
- WAPP Aperture Photometry System
	- WCS World Coordinate System.
- \mathbf{WPHOT} WISE PHOTometry module, described here, which will enable both aperture and profilefitting photometry based on the list of candidates supplied by MDET.
	- WPRO Profile-fitting Photometry System
	- WSDS WISE Science Data System.

2 OVERVIEW OF APPROACH

WPHOT is designed to perform the source position and flux characterization step associated with each of the three stages of source extraction during pipeline processing (single-frame, single-epoch 4-band frameset, and final coadd stage). The characterization is based on an input list of source candidate positions produced by MDET using a detection algorithm which makes use of the data at all bands simultaneously.

Since the majority of sources detected by WISE are expected to be spatially unresolved, the optimal approach for source characterization involves profile-fitting photometry (WPRO). Just as with the detection step, this procedure is carried out using the data from all bands simultaneously. The advantages of simultaneous multiband extraction are:

- 1. Increased sensitivity to weak sources due to the fact that detection is based on the stack of images at all bands.
- 2. No separate bandmerging step is required, thus avoiding the ambiguities which can occur when trying to associate sources in different bands in the presence of confusion.
- 3. The higher resolution data at the shorter wavelengths can guide the extraction at the longer wavelengths where the resolution is poorer.

The multiband estimation process represents a departure from the traditional procedure, employed in such software packages as DAOPHOT (Stetson 1987) and SExtractor (Bertin & Arnouts 1996), in which detection and characterization are carried out one band at a time. Another motivation for developing new source extraction algorithms is that currently available packages operate on a single regularly-sampled image rather than a set of dithered images. The procedures employed in MDET and WPHOT are optimized for the latter case.

In addition to profile-fitting photometry, WPHOT includes an aperture photometry system (WAPP) that employs circular apertures to characterize the integrated flux and 'curve-ofgrowth' of point sources. Morever, in order to properly characterize the subset of sources which are spatially resolved, we will supplement the profile and aperture-fitting results with basic surface brightness and other morphology metrics, depending on the resources that are available for their development.

2.1 Inputs

- 1. List of candidate positions generated by MDET (text file).
- 2. Focal-plane images ("Level 1b frame"); dark-subtracted, flat-fielded, position-calibrated via WCS information in headers (FITS format).
- 3. PSF and corresponding uncertainty map at each band (FITS format).
- 4. Additional noise parameters: pixel gain, read noise.
- 5. Coadded image and corresponding uncertainty image at each band (FITS format).
- 6. Median-filtered background image generated by MDET (FITS format).
- 7. 2MASS XSC to provide prior knowledge of extended sources.
- 8. 2MASS PSC to provide prior knowledge of very bright stars

2.2 Outputs

The output consists of a single file in text format, one line per source, containing the following information:

- 1. Sequential number of source; the ordering is nominally in decreasing SNR.
- 2. Profile-fit results: RA [deg] & Dec [deg] of the source, the estimated flux [dn] at each of the four bands, and the corresponding uncertainties in each of those six quantities.
- 3. Reduced chi squared value for the overall fit and for the individual bands.
- 4. Number of components in the fitted blend, plus a flag which indicates if this source was added via active deblending. individual bands.
- 5. Number of components in the fitted blend, plus a flag which indicates if this source was added via active deblending.
- 6. Aperture photometry results: Source centroid positions and aperture fluxes in a series of apertures centered on the profile-fitted position, in each of the four bands; the corresponding uncertainties in each of those quantities. Additional source characterization measurements, including surface brightness, size and shape.

3 TECHNICAL DESCRIPTION

The data processing steps involved in the source characterization procedure are illustrated in Figure 1. They include:

- 1. Subtract slowly-varying background from each frame using the sky background estimated via median filtering in MDET. This serves as a pre-flattening step which increases the accuracy of subsequent sky background estimation in annuli surrounding the sources.
- 2. Do profile-fitting photometry for all of the candidate sources in detection list from MDET, subtracting the estimated contributions from the focal-plane images after each extraction.
- 3. Do aperture photometry for all of the candidate sources using the original (unsubtracted) focal-plane images, placing the apertures at the locations found during the profile-fitting photometry step. Additional characterization is TBD

3.0.1 Coordinate Transformation

MDET utilizes the level-2 coadded frames to detect sources. The coordinate positions are recorded in the WCS system (equatorial). WPHOT uses level-1 frames to measure fluxes, and as such, requires the detection positions to be in frame coordinates (x,y) . The purpose of this routine is to transform the equatorial coordinates into frame coordinates.

3.0.2 Local Background

The sky background is composed of real astrophysical diffuse signal (e.g., infrared cirrus, zodiacal emission), faint stars (fluctuating at the noise level), and diffuse artifacts (e.g., scattered light, diffraction spikes and latent ghosts). These background components have size scales that range from point-like to infinitely extended (e.g., zodiacal light). What is important with aperture photometry of point sources is the "local" background value.

The local background is determined within a circular annulus centered on the source as reported by MDET. The pixel value distribution is trimmed of outliers and the median average, b_{λ} , represents the local "sky" background level, and the RMS of the distribution. $(\sigma_{bann})_\lambda$, represents the uncertainty in the sky level as measured within an annulus.

The uncertainty in the background sky level due to the finite annulus size used to measure it is expected to be:

$$
\sigma_{ann}^2 = \frac{N_{ap}^2 \left(\sigma_{bann}^2\right)}{N_b} \tag{1}
$$

where N_{ap} is the number of pixels in the photometric aperture, $(\sigma_{bann})_\lambda$ is the uncertainty or RMS of the background sky level measured in the annulus, and N_b is the number of pixels in the annulus.

An alternative measure of the background uncertainty comes from the error propogation that follows the instrument characteristics and the noise model that is tracked by AWAIC and passed to on to WPHOT. With this noise model, the uncertainty in the background sky level is

$$
\sigma_b^2 = \frac{1}{N_b^2} \sum_{i=1}^{N_b} (\sigma_i^2)
$$
\n(2)

where N_b is the number of pixels in the annulus and σ_i is the measurement uncertainty for detector/frame pixel i.

Size Considerations

Choosing the optimal size for the annulus is an important consideration toward accurate photometry. The annulus must be large enough to avoid the influence of the point spread function and to minimize the Poisson component of the sky pixels (see equation below). On the other, it must also be small enough to represent the "local" sky value (that is to say, the fluctuations that are present in the aperture should be of similar amplitude in the annulus).

Moreover, in order to accomodate the possibility of the source being fuzzy galaxy, the annulus should extend beyond the size expected for most galaxies in the sky; see APPENDIX discussion of extended sources. Since the annulus may be large enough to experience gradients in the background, we first subtract the frame images with the median-filtered background (determined by MDET); this effectively flattens the backgrounds on size scales that are set by the median filtering. With this step, the sky determined from the local annulus should reflect the "local" background for the source in question.

2MASS and Spitzer-IRAC Aperture Geometry

Let us first consider what was done with 2MASS. For standard 2MASS point source photometry, the annulus that was used: $R_{inner} = 14''$, $R_{outer} = 20''$, with 2'' pixels that translates to 160 pixels in the annulus. The 2MASS beam is about 2.5", so R_{inner} is ~ 6× FWHM. For the combined calibration fields, 2MASS used a larger annulus, $24 - 30$ " in size, or roughly $\sim 10 \times$ FWHM. The standard calibration aperture for IRAC is $12^{\prime\prime}$, and the annulus is $14.4 - 20^{\prime\prime}$, which compared to the 2" beam is \sim 7 – 10× FWHM.

The WISE Annulus

For WISE, the FWHM=6" for the short channels, and so using 2MASS/IRAC as a guide, the inner radius would be $\sim 40 - 50''$ (and $\sim 80 - 100''$ for WISE-4); with 2.75" pixels, that translates to $R_{inner} \sim 15 - 18$ pixels. For the width, using a similar area as the 2MASS/IRAC annulus, then $R_{outer} \sim 19$ pixels. Since that is a relatively thin aperture, subject to pixelization effects, it would be better to fatten it to a width of 4 - 5 pixels, or $R_{outer} = 20$ - 22. Consequently, the proposed annulus for WISE point sources is: 15 to 22 pixels for WISE-1,2,3,4 Note that WISE-4 will have an annulus that is looking at a different piece of the sky compared to the other channels. The optimal annulus for point and extended sources is TBD.

3.1 Profile fitting photometry (WPRO)

The purpose of this step is to make a maximum likelihood estimate of the source position and the set of fluxes at the four wavelengths for each source candidate identified by the detection module MDET. The candidate source and its neighbors (i.e., adjacent candidates whose PSF responses overlap significantly with the primary candidate) are grouped into blends, and their parameters estimated simultaneously. This procedure is referred to as passive deblending.

For a blend consisting of N_B components, the measurement model is:

$$
\rho_{\lambda i} = \sum_{n=1}^{N_{\rm B}} (f_{\lambda})_n H_{\lambda} (\mathbf{r}_{\lambda i} - \mathbf{s}_n) + b_{\lambda} + \nu_{\lambda i}
$$
\n(3)

where $\rho_{\lambda i}$ is the observed value of the *i*th pixel at sky location $\mathbf{r}_{\lambda i}$ in the waveband denoted by subscript λ , \mathbf{s}_n is the location of the *n*th blend component, $(f_\lambda)_n$ is the flux in the λ th waveband, $H_{\lambda}(\mathbf{r})$ is the PSF, $b_{\lambda i}$ is the local background, estimated in an annulus surrounding the candidate position, and $\nu_{\lambda i}$ is the noise, assumed to be a spatially and spectrally uncorrelated zero-mean Gaussian random process with variance $\sigma_{\lambda i}^2$. The latter quantity includes the various noise components in the error model and may be expressed as:

$$
\sigma_{\lambda i}^2 = (\rho_{\lambda i} - b_{\lambda})/g_{\lambda} + [(\rho_{\lambda i} - b_{\lambda})(\sigma_{\rm ff})_{\lambda}]^2 + (N_{\rm R})_{\lambda}^2 + (\sigma_b)_{\lambda}^2 + [(f_{\rm ap})_{\lambda} \delta H_{\lambda} (\mathbf{r}_{\lambda i} - \mathbf{s}_n)]^2 \tag{4}
$$

where g_{λ} , $(\sigma_{\rm f})_{\lambda}$, $(N_{\rm R})_{\lambda}$ and $(\sigma_{b})_{\lambda}$ represent the pixel gain [counts/dn], flat-fielding error, read noise and standard deviation of the local background, respectively, and $\delta H_\lambda(\mathbf{r})$ represents the PSF uncertainty which must be scaled by the source flux; we use a preliminary estimate of the aperture flux, denoted by $(f_{ap})_{\lambda}$.

The set of unknowns in the estimation process can be represented by an n_{p} -dimensional parameter vector, z, defined as:

$$
\mathbf{z} \equiv [\{\mathbf{s}_n, \{(f_\lambda)_n : \lambda = 1, \dots N_\lambda\} : n = 1, \dots N_\mathrm{B}\}]
$$
\n(5)

where N_{λ} represents the number of wavebands, and the number of unknowns is given by $n_{\rm p}$ = $N_{\rm B}(N_{\lambda}+2)$.

The solution procedure is to maximize the conditional probability $P(\rho | \mathbf{z}, N_B)$ with respect to z, where:

$$
\ln P(\rho | \mathbf{z}, N_{\rm B}) = -\frac{1}{2} \sum_{\lambda} \sum_{i} \frac{1}{\sigma_{\lambda i}^2} [\rho_{\lambda i} - b_{\lambda} - \sum_{n=1}^{N_{\rm B}} (f_{\lambda})_n H_{\lambda} (\mathbf{r}_{\lambda i} - \mathbf{s}_n)]^2 + \text{const.}
$$
(6)

in which the summation over i is for all pixels within some predefined "fitting radius", r_{fit} , of the candidate source location.

The quality of the fit can be evaluated using the reduced chi squared, given by:

$$
\chi_{\nu}^{2} = \frac{1}{N_{\text{obs}} - n_{\text{p}}} \sum_{\lambda} \sum_{i} \frac{1}{\sigma_{\lambda i}^{2}} [\rho_{\lambda i} - b_{\lambda} - \sum_{n=1}^{N_{\text{B}}} (\hat{f}_{\lambda})_{n} H_{\lambda} (\mathbf{r}_{\lambda i} - \hat{\mathbf{s}}_{n})]^{2}
$$
(7)

where N_{obs} represents the total number of pixel values used in the solution, and $(f_{\lambda})_n$ & $\hat{\mathbf{s}}_n$ represent the estimated values of the respective quantities.

If $\chi^2_{\nu} \sim 1$, the fit is regarded as satisfactory. However if χ^2_{ν} is larger than some critical value, $(\chi^2_{\nu})_{\text{crit}} \sim 2$, or if the reduced chi squared for an individual band (denoted $(\chi^2_{\nu})_{\lambda}$) exceeds this threshold, then we consider that the source model has not satisfactorily reproduced the observed data, and we then examine the hypothesis that the true intensity distribution involves additional point source components. In this procedure, referred to as active deblending we successively add more source components (thereby increasing N_B) until either $\chi^2_{\nu} \le (\chi^2_{\nu})_{\text{crit}}$ or else the blend number reaches some predefined limit, $(N_B)_{\text{max}}$, at which point we conclude that a model consisting of a few point sources is not consistent with the observations.

At each iteration of the active deblending procedure, the mechanism for adding a new source component is as follows:

- 1. Construct a source model consisting of N_B components in the locations estimated in the current solution, plus an additional component offset by $(\Delta x, \Delta y)$ from the primary source.
- 2. At each location on a regularly-sampled grid of $(\Delta x, \Delta y)$ in a rectangular region surrounding the primary source, obtain the maximum likelihood solution for the set of $(N_B + 1)$ fluxes of this set of components.
- 3. Calculate the corresponding χ^2_{ν} as a function of $(\Delta x, \Delta y)$.
- 4. Find the minimum of χ^2_{ν} ; we now have a set of $(N_{\rm B}+1)$ component locations which serve as a starting model for a full maximum likelihood solution (position and fluxes).

At this point, two tests are performed to determine whether the new solution (involving the extra component) is warranted by the data:

- 1. Chi squared test (overall and for individual bands) as above. This test determines whether the data (and single-band subsets of the data) are consistent with the model.
- 2. Require that the overall reduced chi squared decrease by at least a minimum amount, i.e. $\Delta \chi^2_{\nu} \geq (\Delta \chi_{\nu})_{\text{min}}$. The difference in chi squared corresponds to a likelihood ratio, and thus indicates the extent to which a model with $(N_B + 1)$ components is more likely than a model with N_B components.

During this active deblending procedure, any source candidates that were missed in the multiband detection (MDET) step due to cross-band blending will be recovered, since these sources will produce large values of $(\chi^2_{\nu})_{\lambda}$ in the band (or bands) in which they have significant strength.

The overall profile-fitting photometry procedure is illustrated by the flowchart in Figure 2; the active deblending procedure is contained within the blue dashed rectangular box.

When a satisfactory solution has been obtained, the uncertainties in the estimated parameters (position and fluxes) are obtained using:

$$
\sigma(z_j)^2 = (\gamma^{-1})_{jj} \tag{8}
$$

where
$$
\gamma \equiv -E \frac{\partial}{\partial z} \frac{\partial^{\mathrm{T}}}{\partial z} \ln P(\rho | \mathbf{z}, N_{\mathrm{B}})
$$
 (9)

in which E is the expectation operator and T denotes transpose.

The way in which the above estimation procedure is implemented is that we start with the brighest source in the candidate list and estimate its parameters as above. We then proceed as follows:

- 1. Write out the source position and multiband fluxes associated with the candidate itself and with any actively-deblended source components (each of which is regarded as a separate source.
- 2. Discard the results for any "passively-deblended" components, i.e., those components corresponding to neighboring candidates in the MDET detection list—these candidates will be processed later.
- 3. Subtract the estimated contributions of the primary source (+ actively-deblended components) from the focal-plane images.

We then repeat the procedure for the next brightest candidate, and so on until the MDET candidate list is exhausted.

Figure 2: WPRO flowchart.

Effect of nonisoplanatic PSF

The above algorithm assumes that the PSF shape, $H_{\lambda}(\mathbf{r})$, is independent of focal-plane position, i.e., independent of i in Equation (3) . It is likely that this assumption will be violated as a result of focal-plane distortion due to the telescope optics, necessitating some allowance for PSF shape variations. A practical way of handling this situation is to use a set of PSFs corresponding to a grid of locations on the focal plane and interpolate between them to find the appropriate PSF shape for a source at a given focal-plane pixel location. The details of this must await further information on the nature of PSF distortion.

3.2 Aperture photometry (WAPP)

Introduction

The WAPP system performs multi-aperture photometry and source characterization, which is carried out after the profile-fitting system (WPRO) has completed; see Figure 1. The WPRO extraction list is used as the input source list for WAPP. In this way every source extracted by WPRO using both passive and active deblending will have an aperture flux.

Figure 3: WAPP flowchart.

Fixed aperture photometry serves several purposes, including

- source flux estimation in support of profile-fitting photometry,
- construction of curve-of-growth data for aperture corrections,
- more accurate flux determination for very bright sources,
- serve as a truth measurement to test the robustness of profile-fitting photometry, and
- accurate source flux determination for extended sources in which the PSF does not accurately model the light distribution.

There are three main parts to the WAPP system: local background determination, aperture photometry, and additional source characterization. The system is described below

3.2.1 Special Inputs

Aperture photometry and source characterization is carried out using Level-1 frame images. Both the frames and their associated masks are inputs to WPHOT. Either single or multi-band frames will be supported. The additional functionality of working on coadded images will be introduced in future versions of WAPP.

The detection list is provided by the profile-fitting system, which has used MDET for its preliminary detection list. The source detections include profile-fit determinations of the positions, flux and its uncertainty, and the reliability of the fit. Finally, each source has an associated local background and uncertainty that is determined by WPHOT before profile fitting is carried out.

Information regarding nearby extended sources (e.g., large galaxies) is provided by the 2MASS XSC, and very bright stars by the 2MASS PSC. The input parameter list provides information that WAPP requires to run, including the frame information (e.g., gain, read noise, pixel scale), local background annulus size, aperture sizes and flux calibration information

3.2.2 Processing Overview

The primary function of WAPP is to carry out circular aperture photometry, and the secondary function is to conduct source characterization. An important step toward these goals is to replace bad or flagged pixels with values that come from neighboring pixels; this step is discussed below. Determination of the local background is another important function that WAPP carries out; discussed in previous sections

Aperture measurements are made for all of the WPRO detections (that is first run in WPHOT), placing the center of the nested apertures on the refined WPRO positions. Flagged or bad pixels are first cleaned from the source region. If the source is suspected to be extended (e.g., poor χ^2 value), then further characterization measurements are carried out; discussed below. The processing flow is depicted in the Aperture Photometry Flowchart

Figure 4: M51 2MASS point sources

3.2.3 Prior Knowledge using 2MASS

Point sources are sometimes superimposed on extended sources (e.g.,

very bright stars or large galaxies) and their flux measurement can be biased by the surrounding/nearby extended emission. Conversely, point-like sources can be spuriously detected on large, extended objects. See the discussion in section "Extended Sources and Advanced Characterization." The figure to the right shows the nearby galaxy M51ab with 2MASS point source detections overlayed. Many of these sources are pieces of the galaxy (e.g., SF/HII regions) or noise bumps that are enhanced by the underlying galaxy light. Without even minimal characterization of the extended source, we have no way of reliably flagging "point" sources that might be contaminated or modified by the underlying emission. At the very least the 2MASS XSC can be used as a "prior" list of extended sources (i.e., galaxies) in the local region. The XSC gives both the location and size/shape of the galaxy, and therefore can be used to alert WPHOT to its presence.

This knowledge could be used with the following logic:

- If the source is located with Rmingal pixels of a known galaxy, then assume the source is the center of the galaxy and treat accordingly (e.g., do not attempt to deblend; characterize assuming extended emission).
- If the source lies within the galaxy' sphere of influence (Rsizegal), then assume the source is affected by the galaxy and treat accordingly (e.g., do not assume it is extended, but is part of the galaxy itself).
- If the source lies with with scale factor of the galaxy size (Rsizegal $* X$), then flag the source as potentially being affected by the galaxy (whether true or not, this flag simply states that there is a big galaxy nearby).
- If the source lies within some radius of a very bright star, then flag the source as potentially corrupted by bright-star artifacts (e.g., diffraction spikes). If the source lies on top of a known very bright star, then treat accordingly (e.g., attempt deblend?). See the example of a very bright star (Beta Pegasus) as seen with 2MASS

3.2.4 Masked pixel substitution

The WISE arrays will be laced with flagged "bad" pixels that we will want to mask or replace with a local background value. For aperture corrections (i.e., curve of growth), sources with bad pixels should be rejected outright. For regular photometry the question becomes how do we replace bad pixels. Simple neighbor substitution (w/ bi-linear interpolation) ? The optimal method is to use the PSF knowledge to compute the most likely value corresponding to

the bad pixel location. This is carried out using the PSF co-variance matrix, which requires aa matrix inversion. It is unknown how much CPU this will require or if the method is even practical. A less accurate but more practical solution would be to use a gaussian weighted moment, where the gaussian width corresponds to the PSF width.

Summary of flagged (bad) pixel processing:

• Reject source if flagged pixel within Rmin (one or two pixels, TBD) of center position; the justification is that the PSF is limited in its ability to accurately estimate the replacement flux near the peak position for undersampled data.

Figure 5: β Peg

- Flagged pixels within TBD radii of the center position should be replaced using a maximum likelihood method that derives from either the actual PSF or a gaussian model of the PSF.
- For flagged pixels well beyond the PSF, the replacement values are derived from neighbor pixel values using bilinear interpolation.

3.2.5 Circular Apertures

Multiple aperture photometry is the primary function of the WAPP system. A set of nested circular apertures centered on the source (as determined by WPRO) provides the "curve of growth" for a source. The aperture sizes range from the smallest APMIN (two or three pixels, TBD) to the largest APMAX which is constrained by the background annulus. The photometry is carried out using code, developed by 2MASS, that is adapted for WISE images. It includes fractional pixel computations and the ability to use non-circular (elliptical) apertures that may be deployed in future version of WAPP.

Figure 6: Circular apertures centered on NGC6703

Formal frame measurements:

$$
aperture\ area,\ N_{ap} = \pi \times R_{ap}^2 \tag{10}
$$

$$
integrated flux, (F_{ap})_{\lambda} = \sum_{i=1}^{N_{ap}} ((f_{\lambda})_i - b_{\lambda})
$$
 (11)

flux uncertainty using
$$
\sigma_{bann}
$$
 (*Eq.1*), $(\sigma_{ap}^2)_{\lambda} = \frac{(F_{ap})_{\lambda}}{G} + (N_{pix} \times (\sigma_{bann}^2)_{\lambda}) + (\sigma_{ann}^2)_{\lambda}$ (12)

flux uncertainty using
$$
\sigma_b
$$
 $(Eq.2)$, $(\sigma_{ap}^2)_{\lambda} = \frac{(F_{ap})_{\lambda}}{G} + [N_{pix} \times (\sigma_b^2)_{\lambda}]$ (13)

where G is the gain (electrons per DN), N_{ap} is the number of pixels in the circular aperture of radius R_{ap} , b_{λ} and $(\sigma_{bann})_{\lambda}$ are the trimmed-median sky background level and RMS in the annulus pixel distribution, respectively, $(\sigma_{ann})_\lambda$ is the uncertainty due to the finite annulus (see Eq. 1), and (σ_b) is the measurement uncertainty detector/frame pixel based on the error model (see Eq. 2).

Formal COADD measurements: TBD

3.2.6 Extended Sources and Advanced Characterization

Extended sources, in the form of fuzzy galaxies and Galactic nebulosity, will be present in every WISE image frame (e.g., see Fig. 5), thus complicating the primary mission goal of detecting, characterizing and cataloging point sources. The basic data reduction must include some level of extended source characterization to properly handle point source photometry and quality assessment of the resulting catalogue. A secondary issue is the scientific potential of the extended sources themselves. WISE will resolve hundreds of thousands of galaxies and its images will contain a rich assortment of Galactic emission, both high surface brightness and diffuse

varieties. WISE data analysis is not scoped or budgeted to properly handle extended sources; consequently, additional source characterization (of extended sources) will be limited and confined to whatever resources are available. In the following we describe various measurements that may or may not be deployed; TBD.

The main issues to consider:

* Primary– Do we attempt to identify extended sources and (potentially) improve the point source photometry that is affected/contaminated by the extended emission?

* Secondary– Do we produce (and validate) images that have calibrated diffuse/extended emission? That is to say, is every pixel, whether it filled with Zody, or cirrus, or a piece of a galaxy have a calibrated surface brightness?.

* Secondary– Do we attempt to detect and characterize discrete extended sources (e.g., galaxies) ? Do we add these measurements into the WISE source catalog(s) ?

There are three basic kinds of resolved or extended sources: discrete, diffuse and a combination of the two. Examples include:

* discrete: galaxies, planetary nebulae, young stellar objects * diffuse: zodical emission, cirrus and Milky Way nebulosity * composite: HII regions, SNRs

There is some overlap between these rough categories. PNs may be more diffuse than discrete; some compact HII regions may be more discrete than diffuse; some galaxies are so diffuse that they are like whispy clouds in space. Zodical emission is so diffuse that it represents a smooth (but not necessarily uniform) background 'light' that will be in every WISE image. Observations that cross the plane of the Milky Way will potentially have every kind of extended source, thus presenting a major challenge for data reduction and source characterization.

At the very least, the WAPP system must have a way to measure the flux of discrete extended sources. Circular apertures that capture a significant fraction of the source light is the basic measurement. Consistent measurements from band-to-band ensure reliable color metrics. A corresponding size metric is another basic measurement. The size of the source determines how large the aperture measurements should be. To these ends, the local background must be measured to a high accuracy in order to remove residual light from the source fluxes.

Reliable fluxes, surface brightnesses and sizes require background, artifact and contaminating source subtraction to allow clean characterization and extraction. Total fluxes, in particular, require very careful image cleaning and subsequent characterization. The usual procedure is to identify nearby stars and remove them by either masking them or subtracting their flux (using a PSF or some other simple model). With local source removed and the local background well determined, it is relatively straight-forward to characterize the discrete source. Complications arise when the source is asymmetric and/or diffuse and amorphous. It is unclear what can be done about Galactic diffuse and concentrated emission. Considerations:

- What do we do about point source measurements that are contaminated by the underlying extended emission?
- To detect extended sources, will the standard point source detector be good enough? For 2MASS we used the same detector to find stars and galaxies, but fuzzies were then processed separately from point-like sources, thus creating two separate catalogues in the end.
- Alternatively, we do not attempt to detect extended source, but instead we use a prior list (e.g., 2MASS XSC & the MSX catalog) to locate and measure extended sources. We use prior measurements (e.g., 2MASS has a full set) to aide in the WISE characterization, thus easing the development resources.
- Do we add extended source measurements to the WISE source catalog? Do we create requirements (at least internally) for a catalogue, or just do a "best effort" and flag the sources accordingly in the WISE catalogue?
- How far do we carry the source characterization beyond simple aperture fluxes? Using a prior list (see above), we may be able to push harder with minimal development.
- Given the mind-boggling confusion and source complexity in the Plane, do we avoid it altogether for extended sources? For 2MASS, we worked in the Plane, but significantly ramped down our expectations (power-throttled by the confusion noise).
- How much are we willing to dedicate to extended source characterization? How much to diffuse measurements? To image cleaning?

Figure 7: Upper panel: IRAC view of NGC6552 in the WISE NEP/CVZ. Lower panel: Resolved galaxies in a SWIRE 3.6um image of the Lockman Hole

4 WPHOT System

WPHOT High-level Routines

Inputs: Parameter list, source detection data, image data & ancillary information

Figure 8: WPHOT high-level routines

5 Schedule

- Peer Review (March, 2008)
- v0 $2/27/08$ prototype (single frame, multi-band), data flow testing Input frames, masks & detection lists – Local backgrounds (stats) – Aperture photometry – Preliminary output table
- v1 6/19/08 payload ground testing; prototype multi-frame Input median-filtered background images – Profile-fitting (active and passive deblending, isoplanatic PSF) – Coadded aperture photometry (prototype multi-frame) – Other source Characterization – Full output table
- V2 2/28/09 Nonisoplanicity capability in WPRO, PSF generation software
- V3 8/4/09 Pre-launch version: Complete functionality, PSF set, optimized parameters
- V3.5 12/30/09 Post-launch tuneup of parameters/code
- V4 9/20/09 Version for final processing; PSFs derived from all available data

6 Issues and Outstanding Work to be Completed

- PSF generation
- Focal Plane-dependent PSFs ??
- Focal Plane-dependent curve-of-growth measurements ?
- Parameter tuning
- Driving thresholds for active deblending
- Coadd measurements
- Upper limits
- Masked/bad-pixel recovery
- Extended sources (no plan to properly deal with)
- Very bright stars & saturated stars

Parameters to determine:

- Set of circular apertures
- Minimum aperture size
- Maximum aperture size
- Annulus geometry
- Bad pixel replacement criteria
- Prior knowledge of galaxies and bright stars
- χ^2 limit to test for extended emission

Local Background Annulus:

- Issue: Minimum/Maximum annulus size?
- Issue: Do we use the same annulus for all four WISE bands, based on WISE-4 ?

What do do about flagged or bad pixels:

- Issue: How close to the central position do we attempt to rectify bad pixels?
- Issue: Do we use the PSF or a gaussian model to compute the maximum likelihood value?
- Issue: What about bad pixels in the annulus?
- Issue: When do we correct for bad pixels? Do we correct for bad pixels in the annulus?

Coadded Frames

- Where do we incorporate coadded frames into WAPP?
- How do we join frame and coadded results into a merged table?

Extended Sources

- Primary– Do we attempt to identify extended sources and (potentially) improve the point source photometry that is affected/contaminated by the extended emission?
- Secondary– Do we produce (and validate) images that have calibrated diffuse/extended emission? That is to say, is every pixel, whether it filled with Zody, or cirrus, or a piece of a galaxy have a calibrated surface brightness?.
- Secondary–Do we attempt to detect and characterize discrete extended sources (e.g., galaxies) ? Do we add these measurements into the WISE source catalog(s) ?
- Issue: What level of characterization do we carry out? (note that there is no budget or charge from the science team to work on extended sources)
- Issue: Bright stars Any special processing that is needed?

7 TEST PLAN Description

Data Sets

- WISE image simulations
- Spitzer NEP/SEP mini-surveys
- Spitzer GLIMPSE/MIPSGAL/SWIRE

• $2MASS+IRAC M67$

General list of items to test WPHOT:

- Integrity & robustness of the algorithms
- Reliability (?2 metric; active deblending; N out of M)
- Completeness in confused instances (WPRO)
- Memory management for deep coverages
- Speed management (active deblending thresholding)

WAPP Annulus/Aperture testing

- Local background statistics; pixel-value histogram statistics.
- Small apertures, to test that the fractional-pixel algorithm is working as designed.
- Large apertures, to test the integrity of the system.
- Full range in fluxes, from noise to bright-saturated stars.

WAPP functionality testing

- Source subtraction
- Intensity moments
- Size and shape measurements
- Surface brightness.
- Source Confusion.

WPRO testing

To test the basic profile-fitting system, a comparison with the WAP aperture photometry and the NEP mini-survey phtometry will be carried out. To test the deblending capabilities of WPRO, simulated data will be used to check both completeness and reliability of the photometry and error model. Since WPRO requires accurate PSFs, these tests will be predicated upon building accurate PSFs with the datasets available for testing. Some specific tests of WPRO will be:

Repeatability tests: Use multiple observations of the same region of sky, in order to check validity of estimated flux and position errors.

Behavior of chi squared: Make plots of reduced chi squared as a function of magnitude for each band, to check the validity of measurement error model.

Active deblending tests:

1. Verify performance using synthetic data for a variety of source separations, including sources which have significant flux in one band only. A particular case of interest is a weak Band 1-only source which is close to a strong Band 4-only source.

2. Determine optimal values of the parameters $(\chi^2_{\nu})_{\text{crit}}$ and $(\Delta \chi^2_{\nu})_{\text{min}}$.

Response to artifacts:

- 1. Examine the behavior of the solution in the vicinity of various possible artifacts, including saturated stars, diffraction spikes, latent images, and electronic crosstalk.
- 2. Examine the effeciveness of χ^2_{ν} for discriminating against spurious solutions and parameter estimates which have been contaminated by artifacts.

Figure 9: Center region of the NEP WISE-CVZ mini-survey by IRAC. The planetary nebula NGC 6543 ("Cats") Eys") and barred galaxy NGC 6552 are prominent objects in the field.

8 Output List of Parameters

TBD

9 REFERENCES

Bertin, E. & Arnouts, S. 1996, A&AS, 117, 393 Stetson, P. B. 1987, PASP, 99, 191